## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Fumio Akikuni

Art Unit : Unknown

Filed

: September 3, 2003

Examiner: Unknown

Title

: OPTICAL INTERFEROMETER

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449.

Under 35 USC §120, this application relies on the earlier filing date of application serial number 09/785,585, filed on February 16, 2001. All references were submitted to and/or cited by the Office in the prior application and, therefore, are not provided in this application.

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Samuel Borodach Reg. No. 38,388

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1	Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10830-058002	Application No.	
	Information Disclosure Statem nt by Applicant (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant Fumio Akikuni		
			Filing Date September 3, 2003	Group Art Unit	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	US 4243323	01/1981	Breckinridge			
	AB	US 6034773	03/2000	Nishimura et al.			
	AC	US 5325226	06/1994	Khoe	!		
	AD	US 6134003	10/2000	Tearney et al.			
	AE	US 6381015 B1	04/2002	Sonehara et al.			
	AF	US 5764361	06/1998	Kato et al.			
	AG	US 5170223	12/1992	Carangelo et al.			
	AH						
	AI						
	AJ						
	AK						

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Translation	
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	0 480 027 A1	15.04.92	EPO				
	AM	61-140802	06.27.1986	Japan			•	
	AN							
	AO							
	AP							

	Other Documents (include Author, Title, Date, and Place of Publication)					
Examiner	Desig.					
Initial	ID	Document				
	AQ					
	AR					
	AS					
	AT					

Examiner Signature	Date Considered				
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with					
next communication to applicant.	· · · <u></u>				